## Notice of References Cited

Application/Control No. 10/575,472	Reexamination	Applicant(s)/Patent Under Reexamination CANSELL ET AL.		
Examiner	Art Unit			
Noah S Wiese	1709	Page 1 of 1		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,552,786	11-1985	Berneburg et al.	427/249.15
*	В	US-6,087,003	07-2000	Benoit et al.	428/403
*	С	US-5,164,348	11-1992	Wood, William P.	501/127
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-		-	
	Т	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Chen et al. Structure, sintering behavior and dielectric properties of silica-coated BaTiO3. Materials Letters 54 (2002) pg 314-317.
Ī	v	Caballero et al. Dopant Distribution and Grain Growth Control in BaTiO3 Ceramics Doped with ZnO-SiO2-P2O5. Journal of the European Ceramic Society 17 (1997) pag 1223-1230.
	w	
	х	

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.